

## COMLINEAR® CLC1009, CLC2009

# 0.2mA, Low Cost, 2.5 to 5.5V, 35MHz Rail-to-Rail Amplifiers

#### FEATURES

- 208µA supply current
- 35MHz bandwidth
- Input voltage range with 5V supply: -0.3V to 3.8V
- Output voltage range with 5V supply: 0.08V to 4.88V
- 27V/µs slew rate
- 21nV/√Hz input voltage noise
- 13mA linear output current
- Fully specified at 2.7V and 5V supplies
- Replaces MAX4281

#### APPLICATIONS

- Portable/battery-powered applications
- Mobile communications, cell phones, pagers
- ADC buffer
- Active filters
- Portable test instruments
- Signal conditioning
- Medical Equipment
- Portable medical instrumentation

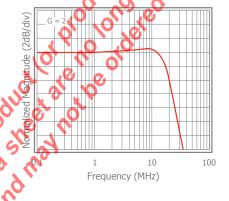
#### **General Description**

The COMLINEAR CLC1009 (single) and CLC2009 (dual) are ultra-low power, low cost, voltage feedback amplifiers. These amplifiers use only  $208\mu A$  of supply current and are designed to operate from a supply range of 2.5V to 5.5V ( $\pm 1.25$  to  $\pm 2.75$ ). The input voltage range extends 300mV below the negative rail and 1.2V below the positive rail.

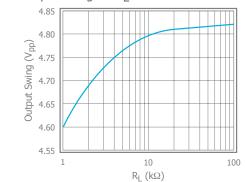
The CLC1009 and CLC2009 offer high pipolar performance at a low CMOS price. They offer superior dynamic performance with a 35MHz small signal bandwidth and 27V/µs slew rate. The combination of lowpower, high bandwidth, and rail-to-rail performance make the CLC1009 and CLC2009 well suited for battery-powered communication/ computing systems.

#### Typical Performance Examples

Frequency Response



Output Swing vs. R

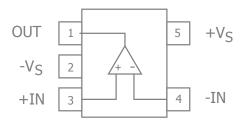


#### **Ordering Information**

Part Number	Package	Pb-Free	RoHS Compliant	Operating Temperature Range	Packaging Method
CLC1009IST5X	SOT23-5	Yes	Yes	-40°C to +85°C	Reel
CLC1009ISO8X	SOIC-8	Yes	Yes	-40°C to +85°C	Reel
CLC2009ISO8X	SOIC-8	Yes	Yes	-40°C to +85°C	Reel

Moisture sensitivity level for all parts is MSL-1.

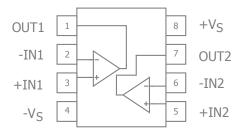
### **CLC1009 Pin Configuration**



#### **CLC1009 Pin Assignments**

Pin No.	Pin Name	Description
1	OUT	Output
2	-V <sub>S</sub>	Negative supply
3	+IN	Positive input
4	-IN	Negative input
5	+V <sub>S</sub>	Positive supply

#### **CLC2009 Pin Configuration**



### **CLC2009 Pin Configuration**

Pin No.	Pin Name	Description
1	OUT1	Output, channel 1
2	-IN1	Negative input channel 1
3	+IN1	Positive input, channel 1
4	-V <sub>S</sub>	Negative supply
5	+IN2	Positive input, channel 2
6	-IN2	Negative input, channel 2
7	OUT2	Output, channel 2
8	+\&	Positive supply

The data and may not be ordered and may not be ordered.

#### **Absolute Maximum Ratings**

The safety of the device is not guaranteed when it is operated above the "Absolute Maximum Ratings". The device should not be operated at these "absolute" limits. Adhere to the "Recommended Operating Conditions" for proper device function. The information contained in the Electrical Characteristics tables and Typical Performance plots reflect the operating conditions noted on the tables and plots.

Parameter	Min	Max	Unit
Supply Voltage	0	6	V
Input Voltage Range	-V <sub>s</sub> -0.5V	+V <sub>S</sub> +0.5V	V
Continuous Output Current	-30	30	mA

#### **Reliability Information**

Parameter	Min	Тур	Max	Unit
Junction Temperature		in	175	°C
Storage Temperature Range	-65	111	150	°C
Lead Temperature (Soldering, 10s)		110	260	°C
Package Thermal Resistance		9, 40		
5-Lead SOT23		221		°C/W
8-Lead SOIC		400		°C/W

Notes:

Package thermal resistance ( $\theta_{\text{JA}}$ ), JDEC standard, multi-layer test boards, still air.

#### **Recommended Operating Conditions**

Recommended Operating Conditions	"Sino as		
Parameter	Min Typ	Max	Unit
Operating Temperature Range	40	+85	°C
Supply Voltage Range	2,8	5.5	V
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#### Electrical Characteristics at +2.7V

 $T_A$  = 25°C,  $V_S$  = +2.7V,  $R_f$  =  $R_g$  =2.5k $\Omega$ ,  $R_L$  = 2k $\Omega$  to  $V_S/2$ , G = 2; unless otherwise noted.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Frequency D	omain Response	<u> </u>		,		
UGBW <sub>SS</sub>	Unity Gain -3dB Bandwidth	$G = +1$ , $V_{OUT} = 0.05V_{pp}$ , $R_f = 0$		28		MHz
BW <sub>SS</sub>	-3dB Bandwidth	$G = +2$ , $V_{OUT} < 0.2V_{pp}$		15		MHz
BW <sub>LS</sub>	Large Signal Bandwidth	$G = +2$ , $V_{OUT} = 2V_{pp}$		7		MHz
GBWP	Gain Bandwdith Product	$G = +11, V_{OUT} = 0.2V_{pp}$		16		MHz
Time Domair	n Response					
t <sub>R</sub> , t <sub>F</sub>	Rise and Fall Time	V <sub>OUT</sub> = 0.2V step; (10% to 90%)		16		ns
t <sub>S</sub>	Settling Time to 0.1%	V <sub>OUT</sub> = 1V step		140		ns
OS	Overshoot	V <sub>OUT</sub> = 1V step		1		%
SR	Slew Rate	2V step, G = -1		20		V/µs
Distortion/No	oise Response	•	1200			
HD2	2nd Harmonic Distortion	V <sub>OUT</sub> = 1V <sub>pp</sub> , 100kHz		-85		dBc
HD3	3rd Harmonic Distortion	V <sub>OUT</sub> = 1V <sub>pp</sub> , 100kHz		-63		dBc
THD	Total Harmonic Distortion	V <sub>OUT</sub> = 1V <sub>pp</sub> , 100kHz	3	62		dB
e <sub>n</sub>	Input Voltage Noise	$V_{OUT} = 1V \text{ step}$ $2V \text{ step, } G = -1$ $V_{OUT} = 1V_{pp}, 100 \text{ kHz}$ $V_{OUT} = 1V_{pp}, 100 \text{ kHz}$ $V_{OUT} = 1V_{pp}, 100 \text{ kHz}$ $> 10 \text{ kHz}$ $V_{OUT} = 0.2V_{pp}, 100 \text{ kHz}$		23		nV/√Hz
X <sub>TALK</sub>	Crosstalk	V <sub>OUT</sub> = 0.2V <sub>pp</sub> , 100kHz		98		dB
DC Performa	nce	all me				
V <sub>IO</sub>	Input Offset Voltage	26, 0		0.8		mV
dV <sub>IO</sub>	Average Drift	(2 Ti Ti		11		μV/°C
I <sub>b</sub>	Input Bias Current	ict of logs		0.37		μΑ
dI <sub>b</sub>	Average Drift	0,0,0		1		nA/°C
I <sub>OS</sub>	Input Offset Current	40, 40, 4		8		nA
PSRR	Power Supply Rejection Ratio (1)	DÇO	56	60		dB
A <sub>OL</sub>	Open-Loop Gain	$V_{OUT} = V_S / 2$		65		dB
$I_{S}$	Supply Current	per channel		185		μΑ
Input Charac	teristics					
R <sub>IN</sub>	Input Resistance	Non-inverting		>10		ΜΩ
C <sub>IN</sub>	Input Capacitance	***		1.4		pF
CMIR	Common Mode Input Range	DC, $V_{CM} = 0V \text{ to } V_S - 1.5$		-0.3 to 1.5		V
CMRR	Common Mode Rejection Ratio	DC, $V_{CM} = 0V \text{ to } V_S - 1.5$		92		dB
Output Chara	acteristics	W.	,			
.,	dand	$R_L = 2k\Omega$ to $V_S/2$		0.08 to 2.6		V
V <sub>OUT</sub>	Output Voltage Swing	$R_L = 10k\Omega$ to $V_S/2$		0.06 to 2.62		V
I <sub>OUT</sub>	Output Current			±8		mA
$I_{SC}$	Short Circuit Output Current			±12.5		mA

#### Notes:

1. 100% tested at 25°C

#### Electrical Characteristics at +5V

 $T_A=25^{o}C,\,V_S=+5V,\,R_f=R_g=2.5k\Omega,\,R_L=2k\Omega$  to  $V_S/2,\,G=2;$  unless otherwise noted.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Frequency D	omain Response	'				
UGBW <sub>SS</sub>	Unity Gain -3dB Bandwidth	$G = +1$ , $V_{OUT} = 0.05V_{pp}$ , $R_f = 0$		35		MHz
BW <sub>SS</sub>	-3dB Bandwidth	$G = +2, V_{OUT} < 0.2V_{pp}$		18		MHz
BW <sub>LS</sub>	Large Signal Bandwidth	$G = +2$ , $V_{OUT} = 2V_{pp}$		8		MHz
GBWP	Gain Bandwdith Product	$G = +11, V_{OUT} = 0.2V_{pp}$		20		MHz
Time Domair	n Response					
t <sub>R</sub> , t <sub>F</sub>	Rise and Fall Time	V <sub>OUT</sub> = 0.2V step; (10% to 90%)		13		ns
t <sub>S</sub>	Settling Time to 0.1%	V <sub>OUT</sub> = 1V step		140		ns
OS	Overshoot	V <sub>OUT</sub> = 1V step		1		%
SR	Slew Rate	2V step, G = -1		27		V/µs
Distortion/No	pise Response		120			
HD2	2nd Harmonic Distortion	$V_{OUT} = 2V_{pp}$ , 100kHz		-78		dBc
HD3	3rd Harmonic Distortion	$V_{OUT} = 2V_{pp}$ , 100kHz		-66		dBc
THD	Total Harmonic Distortion	V <sub>OUT</sub> = 2V <sub>pp</sub> , 100kHz	8	65		dB
e <sub>n</sub>	Input Voltage Noise	> 10kHz		21		nV/√Hz
X <sub>TALK</sub>	Crosstalk	$V_{OUT} = 1V \text{ step}$ $2V \text{ step, } G = -1$ $V_{OUT} = 2V_{pp}, 100 \text{kHz}$ $V_{OUT} = 0.2V_{pp}, 100 \text{kHz}$		98		dB
DC Performa	nce	All M				
V <sub>IO</sub>	Input Offset Voltage (1)	26, 97	-5	-1.5	5	mV
dV <sub>IO</sub>	Average Drift	The internal		20		μV/°C
I <sub>b</sub>	Input Bias Current (1)	"8) No. 003,	-1.3	0.37	1.3	μΑ
dI <sub>b</sub>	Average Drift	diction (Ot		1		nA/°C
I <sub>OS</sub>	Input Offset Current (1)	40, 96, 96		7	130	nA
PSRR	Power Supply Rejection Ratio (1)	DCO (1)	56	60		dB
A <sub>OL</sub>	Open-Loop Gain	V <sub>OUT</sub> = V <sub>S</sub> /2	56	62		dB
I <sub>S</sub>	Supply Current (1)	per channel		208	260	μΑ
Input Charac	teristics	0,0				
R <sub>IN</sub>	Input Resistance	Non-inverting		>10		ΜΩ
C <sub>IN</sub>	Input Capacitance	X X		1.2		pF
CMIR	Common Mode Input Range	36 40		-0.3 to 3.8		V
CMRR	Common Mode Rejection Ratio (1)	DC, $V_{CM} = 0V \text{ to } V_S - 1.5$	65	95		dB
Output Chara	acteristics					
	Input Resistance Input Capacitance Common Mode Input Range Common Mode Rejection Ratio (1) acteristics Output Voltage Swing	$R_L = 2k\Omega$ to $V_S/2$ <sup>(1)</sup>	0.2 to 4.7	0.1 to 4.8		V
V <sub>OUT</sub>	Output Voltage Swing	$R_L = 10k\Omega$ to $V_S/2$		0.08 to 4.88		V
I <sub>OUT</sub>	Output Current			±8.5		mA
I <sub>SC</sub>	Short Circuit Output Current			±13		mA

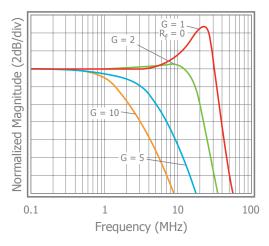
#### Notes:

1. 100% tested at 25°C

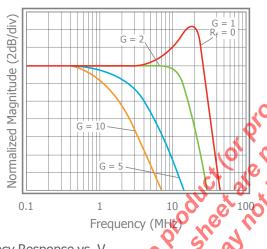
#### Typical Performance Characteristics

 $T_A = 25$ °C,  $V_S = +5V$ ,  $R_f = R_q = 2.5k\Omega$ ,  $R_L = 2k\Omega$  to  $V_S/2$ , G = 2; unless otherwise noted.

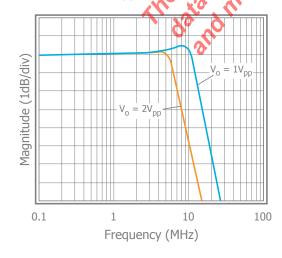
#### Non-Inverting Frequency Response



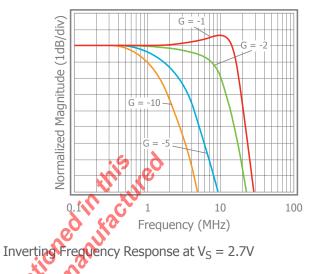
#### Non-Inverting Frequency Response at $V_S = 2.7V$

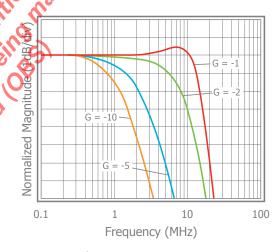


#### Frequency Response vs. V<sub>OUT</sub>

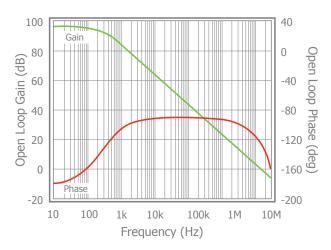


#### Inverting Frequency Response



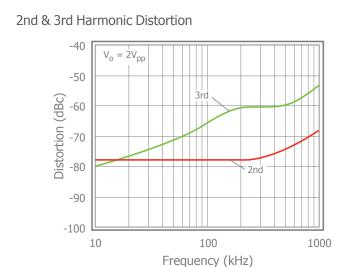


#### Open Loop Gain & Phase vs. Frequency

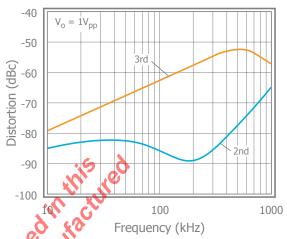


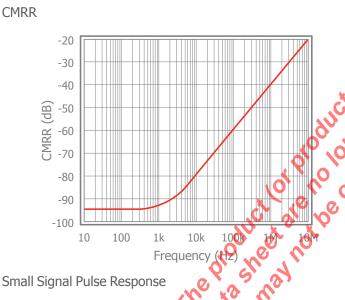
#### Typical Performance Characteristics

 $T_A = 25$ °C,  $V_S = +5V$ ,  $R_f = R_q = 2.5k\Omega$ ,  $R_L = 2k\Omega$  to  $V_S/2$ , G = 2; unless otherwise noted.

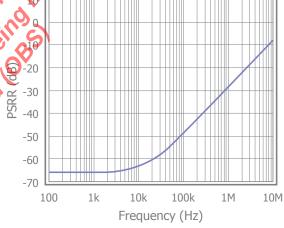




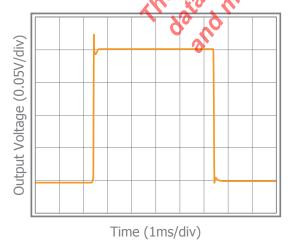




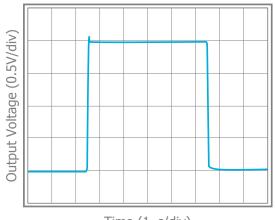








Large Signal Pulse Response

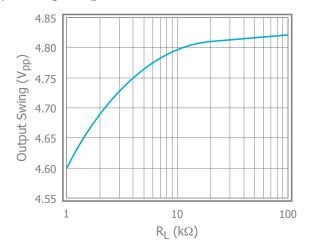


Time (1µs/div)

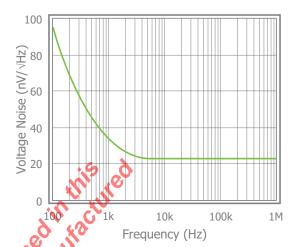
#### Typical Performance Characteristics - Continued

 $T_A=25$  °C,  $V_S=+5V$ ,  $R_f=R_q=2.5k\Omega$ ,  $R_L=2k\Omega$  to  $V_S/2$ , G=2; unless otherwise noted.

#### Output Swing vs. R<sub>L</sub>



#### Input Voltage Noise



The product are no ordered OBS

#### **Application Information**

#### **General Description**

The CLC1009 family are a single supply, general purpose, voltage-feedback amplifiers fabricated on a complementary bipolar process. The CLC1009 offers 35MHz unity gain bandwidth, 27V/µs slew rate, and only 208µA supply current. It features a rail-to-rail output stage and is unity gain stable.

The design utilizes a patent pending topology that provides increased slew rate performance. The common mode input range extends to 300mV below ground and to 1.2V below Vs. Exceeding these values will not cause phase reversal. However, if the input voltage exceeds the rails by more than 0.5V, the input ESD devices will begin to conduct. The output will stay at the rail during this overdrive condition.

The design uses a Darlington output stage. The output stage is short circuit protected and offers "soft" saturation protection that improves recovery time.

Figures 1, 2, and 3 illustrate typical circuit configurations for non-inverting, inverting, and unity gain topologies for dual supply applications. They show the recommended bypass capacitor values and overall closed loop gain equations. Figure 4 shows the typical non-inverting gain circuit for single supply applications.

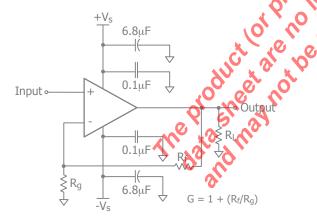


Figure 1. Typical Non-Inverting Gain Circuit

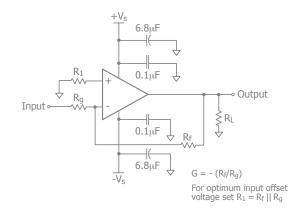


Figure 2. Typica Inverting Gain Circuit

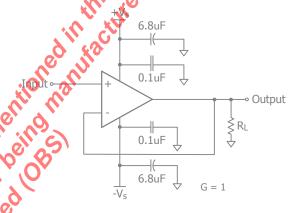


Figure 3. Unity Gain Circuit

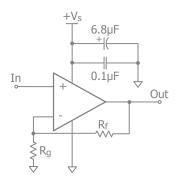


Figure 4. Single Supply Non-Inverting Gain Circuit

#### **Power Dissipation**

Power dissipation should not be a factor when operating under the stated  $2k\Omega$  load condition. However, applications with low impedance, DC coupled loads should be analyzed to ensure that maximum allowed junction temperature is not exceeded. Guidelines listed below can be used to verify that the particular application will not cause the device to operate beyond it's intended operating range.

Maximum power levels are set by the absolute maximum junction rating of 150°C. To calculate the junction temperature, the package thermal resistance value Theta<sub>JA</sub>  $(\Theta_{JA})$  is used along with the total die power dissipation.

$$T_{Junction} = T_{Ambient} + (\Theta_{JA} \times P_{D})$$

Where T<sub>Ambient</sub> is the temperature of the working environment.

In order to determine P<sub>D</sub>, the power dissipated in the load needs to be subtracted from the total power delivered by the supplies.

$$P_D = P_{supply} - P_{load}$$

$$P_{\text{supply}} = V_{\text{supply}} \times I_{\text{RMS supply}}$$
 $V_{\text{supply}} = V_{\text{S+}} - V_{\text{S-}}$ 

$$P_{load} = ((V_{LOAD})_{RMS^2})/Rload_{eff}$$

$$R_L \parallel (R_f + R_g)$$

 $V_{supply} \times I_{RMS \; supply}$   $V_{supply} = V_{S+} - V_{S-}$  delivered to a purely resistive load isk  $P_{load} = ((V_{LOAD})_{RMS^2})/Rload_{eff}$   $\text{The effective load resistor (Rload_{eff}) Will need to include the effect of the feedback network, for instance,}$   $\text{Noad}_{eff} \; \text{in Figure 3 would be calculated as:}$   $\text{Pload}_{eff} \; \text{in Figure 3 would be calculated as:}$   $\text{Pload}_{eff} \; \text{in Figure 3 would be calculated as:}$   $\text{Pload}_{eff} \; \text{in Figure 3 would be calculated as:}$   $\text{Pload}_{eff} \; \text{in Figure 3 would be calculated as:}$   $\text{Pload}_{eff} \; \text{in Figure 3 would be calculated as:}$   $\text{Pload}_{eff} \; \text{in Figure 3 would be calculated as:}$   $\text{Pload}_{eff} \; \text{in Figure 3 would be calculated as:}$ impedance is needed to determine the dissipated power. Here, PD can be found from

$$P_D = P_{Quiescent} + P_{Dynamic} - P_{Load}$$

Quiescent power can be derived from the specified IS values along with known supply voltage, V<sub>Supply</sub>. Load power can be calculated as above with the desired signal amplitudes using:

$$(V_{IOAD})_{RMS} = V_{PFAK} / \sqrt{2}$$

$$(I_{LOAD})_{RMS} = (V_{LOAD})_{RMS} / Rload_{eff}$$

The dynamic power is focused primarily within the output stage driving the load. This value can be calculated as:

$$P_{DYNAMIC} = (V_{S+} - V_{LOAD})_{RMS} \times (I_{LOAD})_{RMS}$$

Assuming the load is referenced in the middle of the power rails or  $V_{supply}/2$ .

The CLC1009 is short circuit protected. However, this may not guarantee that the maximum junction temperature (+150°C) is not exceeded under all conditions. Figure 5 shows the maximum safe power dissipation in the package vs. the ambient temperature for the packages available.



Figure 5. Maximum Power Derating

#### **Driving Capacitive Loads**

Increased phase delay at the output due to capacitive loading can cause ringing, peaking in the frequency response, and possible unstable behavior. Use a series resistance, Rs, between the amplifier and the load to help improve stability and settling performance. Refer to

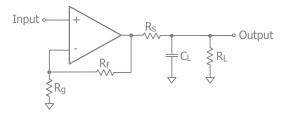


Figure 6. Addition of R<sub>S</sub> for Driving Capacitive Loads

#### Overdrive Recovery

An overdrive condition is defined as the point when either one of the inputs or the output exceed their specified voltage range. Overdrive recovery is the time needed for the amplifier to return to its normal or linear operating point. The recovery time varies, based on whether the input or output is overdriven and by how much the range is exceeded. The CLC1009 and CLC2009 will typically recover in less than 20ns from an overdrive condition.

#### **Layout Considerations**

General layout and supply bypassing play major roles in high frequency performance. CADEKA has evaluation boards to use as a guide for high frequency layout and as an aid in device testing and characterization. Follow the steps below as a basis for high frequency layout:

- Include 6.8µF and 0.1µF ceramic capacitors for power supply decoupling
- Place the 6.8µF capacitor within 0.75 inches of the power pin
- Place the 0.1µF capacitor within 0.1 inches of the power pin
- Remove the ground plane under and around the part, especially near the input and output pins to reduce parasitic capacitance

  Minimize all trace lengths to reduce series in the principle. Remove the ground plane under and around the part,
- Minimize all trace lengths to reduce series inductances

Refer to the evaluation board layouts information.

#### **Evaluation Board Information**

The following evaluation boards are available to aid in the testing and layout of these devices:

Evaluation Board	Products
CEB002	CLC1009 in SOT23
CEB003	CLC1009 in SOIC
CEB006	CLC2009 in SOIC

#### **Evaluation Board Schematics**

Evaluation board schematics and layouts are shown in Figures 8-14. These evaluation boards are built for dualsupply operation. Follow these steps to use the board in a single-supply application:

- 1. Short -Vs to ground.
- 2. Use C3 and C4, if the -V<sub>S</sub> pin of the amplifier is not directly connected to the ground plane.

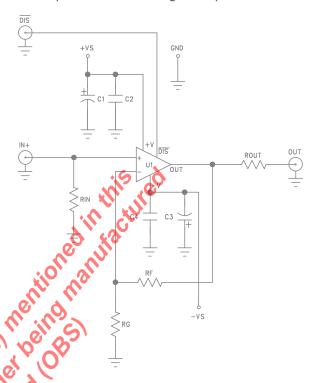


Figure 8. CEB002 & CEB003 Schematic

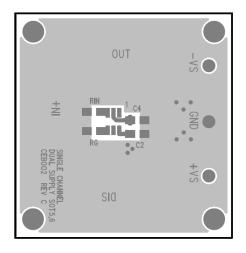
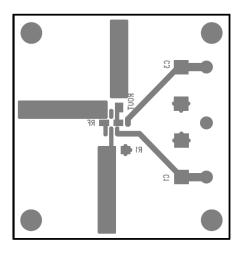
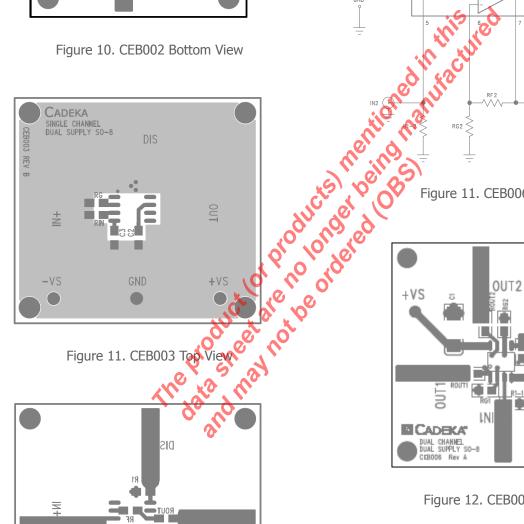


Figure 9. CEB002 Top View





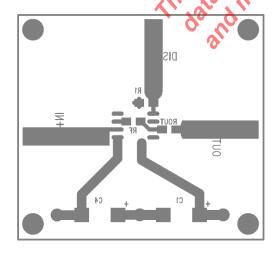


Figure 12. CEB003 Bottom View

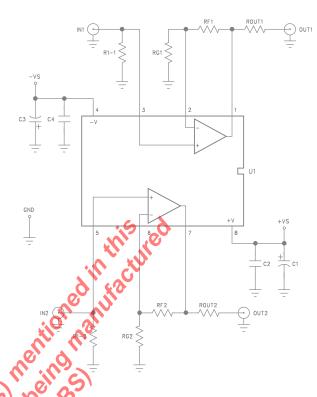


Figure 11. CEB006 Schematic

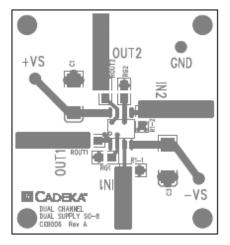


Figure 12. CEB006 Top View

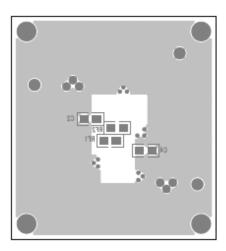
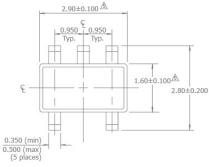


Figure 13. CEB006 Bottom View

The product are no ordered (OBS)

#### **Mechanical Dimensions**

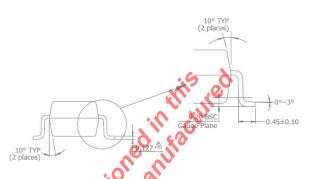
#### SOT23-5 Package



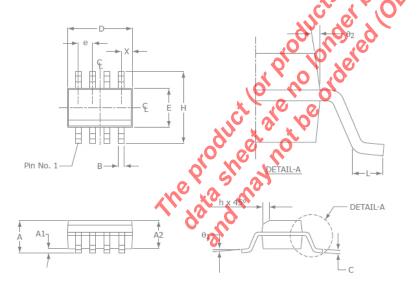
## 10° TYP (2 places) 10° TYP (2 places)

#### NOTES:

- 1. Dimensions and tolerances are as per ANSI Y14.5M-1982.
- 2. Package surface to be matte finish VDI 11~13.
- 3. Die is facing up for mold. Die is facing down for trim/form, ie. reverse trim/form.
- 4. The footlength measuring is based on the guage plane method.
- △ Dimension are exclusive of mold flash and gate burr.
- $\triangle$  Dimension are exclusive of solder plating.



SOIC-8



SOIC-8				
SYMBOL	MIN	MAX		
A1	0.10	0.25		
В	0.36	0.48		
С	0.19	0.25		
D	4.80	4.98		
E	3.81	3.99		
е	1.27	BSC		
Н	5.80	6.20		
h	0.25	0.5		
L	0.41	1.27		
Α	1.37 1.73			
θ1	0° 8°			
Х	0.55 ref			
θ <sub>2</sub>	7º BSC			

- 1. All dimensions are in millimeters.
- 2. Lead coplanarity should be 0 to 0.1mm (0.004") max.
- 3. Package surface finishing: VDI 24~27
- 4. All dimension excluding mold flashes.
- 5. The lead width, B to be determined at 0.1905mm from the lead tip.

The product or products in the ordered (OBS)

#### For Further Assistance:

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